Evaluation of PTB primary caesium fountain frequency standard CSF1 between MJD 58754 - MJD 58784

PTB's primary caesium fountain frequency standard CSF1 was operated between MJD 58754, 0:00 UTC and MJD 58784, 0:00 UTC. Frequency comparisons were made with respect to PTB hydrogen maser H9, BIPM code 1400509.

The relative frequency instability of the relative frequency differences y(CSF1-H9) was $9.7 \times 10^{-14} \cdot (\tau/s)^{-1/2}$ during the 30 days. The actual measurement time amounts to 97.6% of the 30 × 24 hours. This results in a statistical uncertainty $u_{\rm A} = 0.06 \times 10^{-15}$, assuming that white frequency noise is the dominant noise source.

For the uncertainty due to the clock link $u_{Lab} = 0.03 \times 10^{-15}$ is obtained by taking into account the actual measurement time. Finally, the estimated uncertainty for the link to TAI for 30 days is $u_{TAI} = 0.07 \times 10^{-15}$.

Frequency corrections for the following effects were applied to the raw data:

- Zeeman effect (magnetic field along the atoms' trajectory)
- black body effect (thermal radiation along the atoms' trajectory)
- relativistic redshift and relativistic Doppler effect
- cold collisions effect
- distributed cavity phase effect
- microwave lensing effect

The CSF1 standard uncertainty u_B is estimated as 2.8 ×10⁻¹⁶ (1 σ) for the relevant period [1].

Table of results of CSF1 compared to hydrogen maser H9 (1400509)

Interval of evaluation	MJD 58754, 0:00 UTC – MJD 58784, 0:00 UTC
Fractional dead time	2.4%
Resulting frequency difference	$y(CSF1 - H9) = 2.27 \times 10^{-15}$
Type A uncertainty u_A (1 σ)	0.06×10^{-15}
Type B uncertainty u_{B} (1 σ)	0.28×10^{-15}
Link to clock u_{Lab} (1 σ)	$0.03\times10^{\text{-}15}$
Link to TAI <i>u</i> _{TAI} (1 σ)	0.07×10^{-15} (30 days)

Combined uncertainty (1 σ) 0.30 × 10⁻¹⁵

Type A (statistical) uncertainty of CSF1

For the microwave synthesis an optically stabilized microwave oscillator is utilized, which is locked to a hydrogen maser in the long-term [2]. The frequency instability $9.7 \times 10^{-14} (\tau/s)^{-1/2}$ of the measured relative frequency differences y(CSF1 – Hmaser) is obtained for the combination of low and high density operation and gives the statistical measurement uncertainty u_A [1].

The optically stabilized microwave system was almost permanently available (>99%) during the 30 day TAI measurement interval.

Type B (systematic) uncertainty of CSF1

In the table below we report the type B uncertainty evaluation results valid for the evaluation at hand. Detailed descriptions of the systematic uncertainty contributions of CSF1 have been published elsewhere [1].

At the 26th CGPM in November 2018, TAI has been newly defined (Resolution 2). As a result the relativistic redshift of a clock contributing to TAI is to be computed with respect to the conventionally adopted equipotential $W_0 = 62\,636\,856.0\,m^2s^{-2}$ of the Earth's gravity potential. The differentiation relating to the uncertainty of the relativistic redshift for the case of TAI contributions of the PTB fountain clocks in [1] is therefore no longer needed, so that a relativistic redshift uncertainty of 0.02×10^{-16} [1] is attributed now and in the future.

Frequency shifts, corrections and type B uncertainties of CSF1 (parts in 10¹⁶):

Frequency shift	Correction	Uncertainty
Quadratic Zeeman shift	- 1078.35	0.10
Blackbody radiation shift	165.71	0.80
Relativistic redshift and Doppler effect	- 85.56	0.02
Collisional shift	-11.3	2.5
Distributed cavity phase shift	- 0.04	0.93
Microwave lensing	-0.4	0.2
AC Stark shift (light shift)		0.01
Rabi and Ramsey pulling		0.013
Microwave leakage		0.01
Electronics		0.1
Background gas collisions		0.4
Total type B uncertainty		2.8

References

[1] S. Weyers, V. Gerginov, M. Kazda, J. Rahm, B. Lipphardt, G. Dobrev and K. Gibble, Metrologia **55**, pp. 789–805 (2018), <u>https://doi.org/10.1088/1681-7575/aae008</u>

[2] B. Lipphardt, V. Gerginov, S, Weyers, IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control **64**, pp. 761–766 (2017), <u>https://ieeexplore.ieee.org/document/7807353</u>